

2.5. ELECTRON DIFFRACTION AND ELECTRON MICROSCOPY IN STRUCTURE DETERMINATION

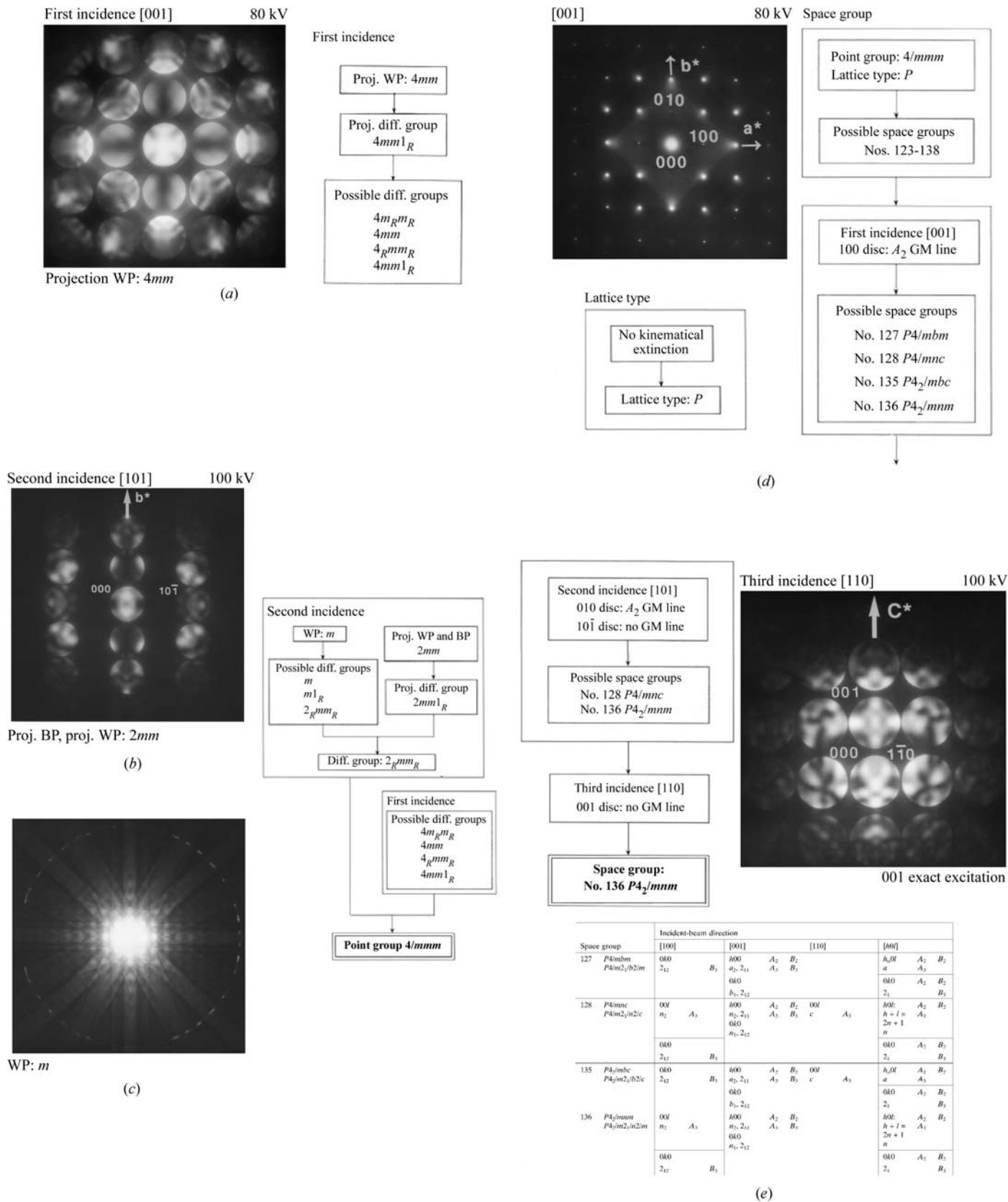


Fig. 2.5.3.15. CBED patterns of rutile. The procedures for identifying the symmetry are also shown. (a) [001] incidence at 80 kV: the projection (proj.) WP shows symmetry $4mm$. (b, c) [101] incidence at 100 kV: the projection BP and projection WP show symmetry $2mm$ and the WP shows symmetry m (the point group is $4/mmm$). (d) Spot diffraction pattern showing no extinction caused by the lattice type (lattice type P). (e) Near-[110] incidence at 100 kV to excite exactly the 001 reflection: no extinction lines in the 001 disc (space group $P4_2/mmm$).

c direction. Later, some corrections to the tables were made by Yamamoto *et al.* (1985). The analysis of incommensurately modulated crystals using $(3 + 1)$ -dimensional space groups has become familiar in the field of X-ray structure analysis.

Fung *et al.* (1980) applied the CBED method to the study of incommensurately modulated transition-metal dichalcogenides.

Steeds *et al.* (1985) applied the LACBED method (Tanaka *et al.*, 1980) to the study of incommensurately modulated crystals of $NiGe_{1-x}P_x$. Tanaka *et al.* (1988, pp. 74–81) examined the symmetries of the incommensurate and fundamental reflections appearing in the CBED patterns obtained from the incommensurately modulated crystals of $Sr_2Nb_2O_7$ and Mo_8O_{23} . Terauchi &